Stat 212b:Topics in Deep Learning Lecture 19

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Planning of remaining lectures

- Lecture 19
 - Optimization, Estimation and Approximation
 - -Stochastic optimization
 - -First order methods, Nesterov Momentum
- Lecture 20: Guest Speaker: Soumith Chintala (FAIR)
- Lecture 21
 - -Fighting Overfitting: Dropout
 - -Fighting Covariance Shift: Batch Normalization
- Lecture 22
 - -Tensor Methods, SDPs and Optimization.
 - -Statistical Physics
- Lecture 23: Guest Speaker: Yann Dauphin (FAIR)
- Lectures 24-25: Oral Presentations/ Open Problems.

• So far, we have seen models that attempt to estimate a density of the input domain $x \in \mathbb{R}^n$

$$p(x) = \int p(h)p(x|h)dh , \ p(x|h) = \exp(\langle \theta_h, \Phi(x) \rangle - A(\theta_h))$$
$$p(x) = p_0(\Phi(x)) \cdot |\det \nabla \Phi(x)|^{-1}$$

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• Chained Bayes Rule: for any ordering $(x_{\sigma(1)}, \ldots, x_{\sigma(n)})$ of the coordinates we have

$$p(x) = \prod_{i \le n} p(x_{\sigma(i)} | x_{\sigma(1)} \dots x_{\sigma(i-1)})$$

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• Q: In which situations is it better to use the factorized?

- Temporally ordered data
 - Speech, Music
 - -Video
 - Language
 - Other time series (Weather, Finance, ...)
- Spatially ordered data, Multi-Resolution data –Images
- Learning is thus reduced to the problem of conditional prediction.

$$p(x) \to \{p(x_i | x_{N(i)})\}_i$$

• Unsupervised learning "success story".



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Language creates a notion of similarity between words: words w₁, w₂ are similar if they are "exchangeable" i.e., they appear often within the same context.

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 w_1

 w_2

• Language creates a notion of similarity between words: words w_1 , w_2 are similar if they are "exchangeable" i.e., they appear often within the same context.

 w_k

• Goal: find a word representation $\Phi(w_i) \in \mathbb{R}^d$ that expresses this similarity as a dot product

 $sim(w_i, w_j) \approx \langle \Phi(w_i), \Phi(w_j) \rangle$.

- Main idea: Skip-gram with negative sampling.
- Construct a "training set"
 - positive pairs $\mathcal{D} = \{(w_k, c_k)\}_k$ of (words, contexts) appearing in a huge language corpus.
 - negative pairs $\mathcal{D}' = \{(w_{k'}, c_{k'})\}_{k'}$ of (words, contexts) not appearing in the corpus.

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- Model the probability of a pair (w, c) being positive as $p(D = 1|c, w) = \sigma(\langle v_w, v_c \rangle), v_w, v_c \in \mathbb{R}^d$. $\sigma(x) = \frac{1}{1 + e^{-x}}$

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- Model the probability of a pair (w, c) being positive as $p(D = 1|c, w) = \sigma(\langle v_w, v_c \rangle), v_w, v_c \in \mathbb{R}^d$. $\sigma(x) = \frac{1}{1 + e^{-x}}$
- Training with Maximum Likelihood: $\arg \max_{\theta} \prod_{\substack{(w,c) \sim \mathcal{D} \\ end{tabular}}} p(D = 1|c, w, \theta) \prod_{\substack{(w,c) \sim \mathcal{D}' \\ end{tabular}}} p(D = 0|c, w, \theta)$ $\arg \max_{\theta} \sum_{\substack{(w,c) \sim \mathcal{D} \\ end{tabular}}} \log \sigma(\langle v_w, v_c \rangle) + \sum_{\substack{(w,c) \sim \mathcal{D}' \\ end{tabular}}} \log \sigma(-\langle v_w, v_c \rangle)$ $\mathcal{D}: \text{ positive contexts} \qquad \mathcal{D}': \text{ negative contexts}$

- Can be seen as an implicit matrix factorization using a mutual information criteria [Yoav & Goldberg, 14].
- Huge impact on Google's business bottom-line.



Video Prediction

- Rather than modeling the density of natural images $p(x) \ , \ x \in \mathbb{R}^d$
- we may be also interested in modeling the conditional distributions $p(x_{t+1}|x_1, \ldots, x_t)$ where $(x_t)_t$ is temporally ordered data.

Video Prediction

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- we may be also interested in modeling the conditional distributions $p(x_{t+1}|x_1, ..., x_t)$ where $(x_t)_t$ is temporally ordered data.
- Similarly, can we find a signal representation $\Phi(x_t)$ that is consistent with the "video language" metric? i.e.

$$\langle \Phi(x_t), \Phi(x_s) \rangle \approx h(|t-s|)$$

 This is the objective of Slow Feature Analysis [Sejnowski et al'02, Cadieu& Olshausen'10 and many others].

Video Prediction

• [Mathieu, Couprie, LeCun, 16]: Conditional video prediction using CNNs and an adversarial cost:



Ground truth



 ℓ_2 result



Adversarial result



Adversarial+GDL result



Ground truth



Adversarial result



 ℓ_2 result



Adversarial+GDL result

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Patch Relative Configuration [Doerch et al.'15]

 Generalize the idea of positive, negative pairs to a multiclass classification problem about spatial configurations.



Patch Relative Configuration [Doerch et al.'15]



- Premise: A patch representation $\Phi(x)$ that does well in this task indirectly builds object priors.
- The criterion is not generative, but it retains enough information to generalize to other tasks.

Patch Relative Configuration [Doerch et al.'15]

• Retrieval tasks:



• The representation captures visual similarity, leveraged in object detection, retrieval, etc.

Pixel Recurrent Networks

• Prediction tasks of the form $\hat{x_{t+1}} = F(x_1, \dots, x_t)$ require a loss or an associated likelihood

e.g. $\|\hat{x}_{t+1} - x_{t+1}\|^2 \iff p(x_{t+1}|x_1, \dots, x_t) = \mathcal{N}(F(x_1, \dots, x_t), I)$

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- In discrete domains we simply use a multinomial loss, in continuous domains there is no principled choice.
- How about images?

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- In discrete domains we simply use a multinomial loss, in continuous domains there is no principled choice.
- How about images?
 - We can treat them as discrete two-dimensional grids $x(u) \in \{0, 255\}$
 - Model each pixel from its "past" context: $p(x(u)|x(v); v \in \Omega(u)) = \operatorname{softmax}\left(\Phi(x, \Omega(u))\right)$

• Conte

- Multi-: resolu
- Very (



Pixel Recurrent Networks [v.d.Oord et al'16]

• State-of-the-art image generation and modeling.



Pixel Recurrent Networks [v.d.Oord et al'16]

occluded completions original

completions

occluded

original







• MNIST and Cifar-10 log-likelihoods:

Model	NLL Test
DBM 2hl [1]:	≈ 84.62
DBN 2hl [2]:	pprox 84.55
NADE [3]:	88.33
EoNADE 2hl (128 orderings) [3]:	85.10
EoNADE-5 2hl (128 orderings) [4]:	84.68
DLGM [5]:	≈ 86.60
DLGM 8 leapfrog steps [6]:	≈ 85.51
DARN 1hl [7]:	≈ 84.13
MADE 2hl (32 masks) [8]:	86.64
DRAW [9]:	≤ 80.97
Diagonal BiLSTM (1 layer, $h = 32$):	80.75
Diagonal BiLSTM (7 layers, $h = 16$):	79.20

Table 4. Test set performance of different models on MNIST in *nats* (negative log-likelihood). Prior results taken from [1] (Salakhutdinov & Hinton, 2009), [2] (Murray & Salakhutdinov, 2009), [3] (Uria et al., 2014), [4] (Raiko et al., 2014), [5] (Rezende et al., 2014), [6] (Salimans et al., 2015), [7] (Gregor et al., 2014), [8] (Germain et al., 2015), [9] (Gregor et al., 2015).

Model	NLL Test (Train)
Uniform Distribution:	8.00
Multivariate Gaussian:	4.70
NICE [1]:	4.48
Deep Diffusion [2]:	4.20
Deep GMMs [3]:	4.00
RIDE [4]:	3.47
PixelCNN:	3.14 (3.08)
Row LSTM:	3.07 (3.00)
Diagonal BiLSTM:	3.00 (2.93)

Table 5. Test set performance of different models on CIFAR-10 in *bits/dim.* For our models we give training performance in brackets. [1] (Dinh et al., 2014), [2] (Sohl-Dickstein et al., 2015), [3] (van den Oord & Schrauwen, 2014a), [4] personal communication (Theis & Bethge, 2015).

Self-supervised vs Unsupervised

- Two views on the same underlying problem: How to measure errors in our models?
 - Self-supervision finds useful proxies that ensure enough discriminative information is kept.
 - -Unconditional probabilistic models define a similarity kernel via the Fisher kernel.

• Depending on the application/ dataset, the indirect route might be more effective than the direct one.

Optimization in Deep Learning

• Our general problem is of the form

$$\min_{\Phi} \mathbb{E}_{z \sim \pi} f(z; \Phi) := F(\Phi) .$$

Supervised Learning: z = (x, y) $f(x, y; \Phi) = \log p(y|x; \Phi) = \ell(y, \Phi(x))$ π : joint data/labels distribution

Unsupervised Learning: z = x $f(x; \Phi) = \log \Phi(x)$ π : data distribution

$$\min_{\Phi} \mathbb{E}_{z \sim \pi} f(z; \Phi) := F(\Phi) .$$

- Challenges:
 - $\mathit{Statistical}$: The function F to be optimized is unknown: only access to an estimator

$$\hat{F}_n(\Phi) = \frac{1}{n} \sum_{i \le n} f(z_i, \Phi) , \ \{z_i\}_{i \le n} : \text{training set.}$$

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-Analytical: In practice, we search within a parametric functional class

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-Numerical: Algorithms to optimize \hat{F}_n .

- –What can we say when \hat{F}_n is non-convex?
- –What is the convergence rate of iterative solutions to stationary points? $\|\Theta^{(k)} \Theta^*\| = O(h(k)) \ .$

Decomposition of Error

[Bottou, Bousquet '08]

Define

 $\Phi^* = \arg\min_{\Phi} F(\Phi)$, optimal model,

 $\Phi_{\mathcal{F}}^* = \arg\min_{\Phi\in\mathcal{F}} F(\Phi) , \text{ optimal achievable model in } \mathcal{F} ,$ $\Phi_{\mathcal{F},n} = \arg\min_{\Phi\in\mathcal{F}} \hat{F}_n(\Phi) , \text{ optimal empirical model in } \mathcal{F} ,$

 $\widetilde{\Phi}_{\mathcal{F},n} =$ solution of our optimization of $\min_{\Phi \in \mathcal{F}} \widehat{F}_n(\Phi)$,

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• Remark: we can also modify empirical risk minimization with a regularizer (structured risk minimization):

$$\hat{F}_n(\Theta) = \frac{1}{n} \sum_{i \le n} f(z_i, \Phi(\Theta)) + \lambda \mathcal{R}(\Theta) ,$$

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 $\widetilde{\Phi}_{\mathcal{F},n} =$ solution of our optimization of $\min_{\Phi \in \mathcal{F}} \widehat{F}_n(\Phi)$,

• Regret is decomposed as

$$F(\widetilde{\Phi}_{\mathcal{F},n}) - F(\Phi^*) = F(\Phi^*_{\mathcal{F}}) - F(\Phi^*) \qquad \text{(approximation error)} \\ + F(\Phi_{\mathcal{F},n}) - F(\Phi^*_{\mathcal{F}}) \qquad \text{(estimation error)} \\ + F(\widetilde{\Phi}_{\mathcal{F},n}) - F(\Phi_{\mathcal{F},n}) \quad \text{(optimization error)}$$

Constrained Approximation, Estimation and Optimization

[Bottou, Bousquet '08]

• Our goal is thus to minimize regret with respect to

model \mathcal{F} , optimization tolerance ρ , number of examples n

subject to $n \leq n_{max}$, compute time $T \leq T_{max}$

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- Our goal is thus to minimize regret with respect to model \mathcal{F} , optimization tolerance ρ , number of examples nsubject to $n \leq n_{max}$, compute time $T \leq T_{max}$
- Constrained optimization trade-offs:

Approximation error decreases as \mathcal{F} gets larger

Estimation error decreases as n gets larger. Estimation error increases as \mathcal{F} gets larger.

Optimization error increases as ρ gets larger.

Two learning regimes

[Bottou, Bousquet '08]

• Small-scale learning problems: the active constraint is the number of examples: $n = n_{max}$.

• Large-scale learning problems: the active constraint is the maximum computation time: $T = T_{max}$.

Two learning regimes

[Bottou, Bousquet '08]

- Small-scale learning problems: the active constraint is the number of examples: $n = n_{max}$.
- Large-scale learning problems: the active constraint is the maximum computation time: $T = T_{max}$.
- Statistical Learning Theory is mostly concerned with smallscale learning problems.
- Whereas small-scale learning problems can neglect the role of the optimization, large-scale problems cannot: generally it is not a good choice to fully optimize the empirical objective function.

• Q: How to control the estimation error?

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For a given $\Phi \in \mathcal{F}$, we consider

$$F(\Phi) - F_n(\Phi) = \mathbb{E}(f_{\Phi}(Z)) - \frac{1}{n} \sum_i f_{\Phi}(Z_i)$$

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A first idea is to use Hoeffding's inequality:

$$P\left(\left|\mathbb{E}(f(Z)) - \frac{1}{n}\sum_{i\leq n} f(Z_i)\right| > \epsilon\right) \leq 2\exp\left(-\frac{2n\epsilon^2}{b^2}\right) , \text{ for } f(Z) \in [0,b] .$$

It results that for any Φ and $\delta > 0$, with probability at least $1 - \delta$,

$$F(\Phi) \le F_n(\Phi) + b\sqrt{\frac{\log 2/\delta}{2n}}$$

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Is this useful?

• We need to control the uniform deviations:

$$\sup_{\Phi\in\mathcal{F}}|F(\Phi)-F_n(\Phi)|$$

• We need to control the uniform deviations:

$$\sup_{\Phi \in \mathcal{F}} |F(\Phi) - F_n(\Phi)|$$

Suppose first that \mathcal{F} is finite: $\mathcal{F} = \{\Phi_1, \ldots, \Phi_N\}.$

For each member j of the family, Hoeffding says that the bad samples

$$C_j = \{z_i; i \le n; |F(\Phi_j) - F_n(\Phi_j)| \ge \epsilon\}.$$

have low probability: $P(C_j) \leq \delta$ for all j.

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Union bound:
$$P(\bigcup_{j \le N} C_j) \le \sum_j P(C_j) \le N\delta$$
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Union bound: $P(\bigcup_{j \le N} C_j) \le \sum_j P(C_j) \le N\delta$.

It results that for all $\delta > 0$ whp $1 - \delta$

$$\forall \Phi \in \mathcal{F}, |F(\Phi) - F_n(\Phi)| \le \sqrt{\frac{\log N - \log \delta}{2n}}.$$

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- We recover the previous bound via the so-called VCdimension of the class. In the binary classification setting:

The VC dimension of a class \mathcal{F} is the size of the largest set $\{z_1, \ldots, z_n\}$ such that \mathcal{F} can generate any classification result.

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• For example, half-spaces in d dimensions have VC dimension d+1.

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The VC dimension of a class \mathcal{F} is the size of the largest set $\{z_1, \ldots, z_n\}$ such that \mathcal{F} can generate any classification result.

If \mathcal{F} has VC-dim d, with probability $1 - \delta$

$$\sup_{\Phi \in \mathcal{F}} |F(\Phi) - F_n(\Phi)| \lesssim \sqrt{\frac{d \log n}{n}} .$$

Back to Estimation Error

• Using the previous bound we thus have

$$F(\Phi_{\mathcal{F},n}) - F(\Phi_{\mathcal{F}}^*) = (F(\Phi_{\mathcal{F},n}) - F_n(\Phi_{\mathcal{F},n})) + (F_n(\Phi_{\mathcal{F},n}) - F_n(\Phi_{\mathcal{F}}^*)) + (F_n(\Phi_{\mathcal{F}}^*) - F(\Phi_{\mathcal{F}}^*))$$

$$\leq 2 \sup_{\Phi \in \mathcal{F}} |F(\Phi) - F_n(\Phi)|$$

$$\lesssim \sqrt{\frac{d}{n}}.$$

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• This bound is pessimistic.

-Faster rates are available e.g. $O\left(\left(\frac{d}{n}\log\frac{n}{d}\right)^{\alpha}\right)$ for $\alpha \in [1/2, 1]$.

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• Joint Estimation and Optimization error:

$$\mathcal{E}_{\text{est}} + \mathcal{E}_{\text{opt}} \simeq O\left(\left(\frac{d}{n}\log\frac{n}{d}\right)^{\alpha}\right) + \rho$$
.

-so in practice we should choose $\rho \simeq O\left(\left(\frac{d}{n}\log\frac{n}{d}\right)^{\alpha}\right)$

Influence of the Approximation Class

- For large datasets, we may want to use larger, richer approximation classes (e.g. huge Convnets).
 - Complexity bounds are intrinsically pessimistic, not realistic.
- Regularization (structured risk minimization) entangles further the optimization and capacity of the signal class.

• Q: For a fixed signal class, how to make a principled choice of optimization algorithm?

Iterative Optimization Algorithms

- [Bottou & Bousquet '08] study four main iterative algorithms in the large-scale learning regime:
 - -Gradient Descent
 - -Second Order Gradient Descent (i.e. Newton method)
 - -Stochastic Gradient Descent (SGD)
 - -Second Order Gradient Descent.
- Assumptions:
 - Signal class \mathcal{F} is fixed,
 - -linearly parametrized by $w \in \mathbb{R}^d$: $\Phi_w(x) = \langle \Phi(x), w \rangle$. loss functions $w \mapsto \ell(\Phi_w(x), y)$ convex and twice differentiable.

Iterative Optimization

• Let H and G be respectively the Hessian and gradient covariance matrices at the empirical optimum $w_n = \arg \min_w F_n(\Phi_w)$:

$$H = \frac{\partial^2 F_n}{\partial w^2} (\Phi_{w_n}) = \frac{1}{n} \sum_i \frac{\partial^2 \ell(\Phi_w(x_i), y_i)}{\partial w^2}$$
$$G = \frac{1}{n} \sum_i \left(\frac{\partial \ell(\Phi_w(x_i), y_i)}{\partial w} \right) \left(\frac{\partial \ell(\Phi_w(x_i), y_i)}{\partial w} \right)^T$$

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• Suppose that

$$\lambda(H) \subset [\lambda_{min}, \lambda_{max}]$$
, with $\lambda_{min} > 0$
 $tr(GH^{-1}) \leq \nu$.

• Condition number: $\kappa = \lambda_{max} / \lambda_{min}$.

Gradient Descent (GD)

$$w_{t+1} = w_t - \eta \nabla_w F_n(\Phi_{w_t}) .$$

• When step size $\eta = \lambda_{max}^{-1}$, $O(\kappa \log(\rho^{-1}))$ iterations to reach accuracy ρ (linear convergence).

	Cost per	Iterations	Time to reach	Time to reach
	iteration	to reach ρ	accuracy ρ	$F(\tilde{\Phi}_n) - F(\Phi_{\mathcal{F}}^* < \epsilon$
GD	O(nd)	$O(\kappa \log \rho^{-1})$	$O(nd\kappa\log\rho^{-1})$	$O\left(d^2\kappa\epsilon^{-1/\alpha}\log^2(\epsilon^{-1})\right)$

Second Order Gradient Descent

$$w_{t+1} = w_t - H^{-1} \nabla_w F_n(\Phi_{w_t})$$
, H^{-1} known in advance.

	Cost per	Iterations	Time to reach	Time to reach
	iteration	to reach ρ	accuracy ρ	$F(\tilde{\Phi}_n) - F(\Phi_{\mathcal{F}}^* < \epsilon$
GD	O(nd)	$O(\kappa \log \rho^{-1})$	$O(nd\kappa\log\rho^{-1})$	$O\left(d^2\kappa\epsilon^{-1/\alpha}\log^2(\epsilon^{-1})\right)$
2GD	O((n+d)d)	$O(\log \log \rho^{-1})$	$O((n+d)d\log\log\rho^{-1})$	$O\left(d^2\epsilon^{-1/\alpha}\log\log(\epsilon^{-1})\log(\epsilon^{-1})\right)$

- Optimization speed is much faster
- The problem does not depend on condition number.

Stochastic Gradient Descent (SGD)

• At each t, we draw random z_t from training set.

$$w_{t+1} = w_t - \frac{\eta}{t} \nabla_w f(\Phi_w(z_t)) .$$

• With
$$\eta = \lambda_{min}^{-1}$$
, we have $||w_t - w_n|| = O(1/\sqrt{t})$.

	Cost per	Iterations	Time to reach	Time to reach
	iteration	to reach ρ	accuracy ρ	$F(\tilde{\Phi}_n) - F(\Phi_{\mathcal{F}}^*) < \epsilon$
GD	O(nd)	$O(\kappa \log \rho^{-1})$	$O(nd\kappa\log\rho^{-1})$	$O\left(d^2\kappa\epsilon^{-1/\alpha}\log^2(\epsilon^{-1})\right)$
2GD	O((n+d)d)	$O(\log \log \rho^{-1})$	$O((n+d)d\log\log\rho^{-1})$	$O\left(d^2\epsilon^{-1/\alpha}\log\log(\epsilon^{-1})\log(\epsilon^{-1})\right)$
SGD	O(d)	$\nu \kappa^2 \rho^{-1} + o(\rho^{-1})$	$O(\frac{d\nu\kappa^2}{\rho})$	$O(\frac{d\nu\kappa^2}{\epsilon})$

- Optimization speed is much worse than GD.
- However, learning speed is better.

Second Order Stochastic Gradient Descent (2SGD)

• At each t, we draw random z_t from training set.

$$w_{t+1} = w_t - \frac{H^{-1}}{t} \nabla_w f(\Phi_w(z_t)) .$$

	Cost per	Iterations	Time to reach	Time to reach
	iteration	to reach ρ	accuracy ρ	$F(\tilde{\Phi}_n) - F(\Phi_{\mathcal{F}}^*) < \epsilon$
GD	O(nd)	$O(\kappa \log \rho^{-1})$	$O(nd\kappa\log\rho^{-1})$	$O\left(d^2\kappa\epsilon^{-1/\alpha}\log^2(\epsilon^{-1})\right)$
2GD	O((n+d)d)	$O(\log \log \rho^{-1})$	$O((n+d)d\log\log\rho^{-1})$	$O\left(d^2\epsilon^{-1/\alpha}\log\log(\epsilon^{-1})\log(\epsilon^{-1})\right)$
SGD	O(d)	$\nu \kappa^2 \rho^{-1} + o(\rho^{-1})$	$O(\frac{d\nu\kappa^2}{\rho})$	$O(\frac{d\nu\kappa^2}{\epsilon})$
2SGD	$O(d^2)$	$\nu \rho^{-1} + o(\rho^{-1})$	$O(\frac{d^2\nu}{ ho})$	$O(\frac{d^2\nu}{\epsilon})$

- Iteration is more expensive, but less iterations.
- Constants are affected.

Accelerated Gradient Descent

- Gradient descent has rate I/T after T steps. Lower bound is I/T^2 amongst first order methods.
- Q: How to improve using a first order method?

Accelerated Gradient Descent

- Gradient descent has rate I/T after T steps. Lower bound is I/T^2 amongst first order methods.
- Q: How to improve using a first order method?
- Use a momentum term (Nesterov,'83):

$$\begin{split} \lambda_0 &= 0 \ , \ \lambda_t = \frac{1 + \sqrt{1 + 4\lambda_{t-1}^2}}{2} \ , \ \gamma_t = \frac{1 - \lambda_t}{\lambda_{t+1}} \ . \end{split}$$
$$\begin{aligned} y_{t+1} &= x_t - \frac{1}{\beta} \nabla f(x_t) \ , \\ x_{t+1} &= (1 - \gamma_t) y_{t+1} + \gamma_t y_t \ . \end{split}$$

Geometric Interpretation

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